

**Search Notes**

Application/Control No.

10/706,323

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under  
Reexamination

HIGA ET AL.

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	40,47,63 71,44	4/13/2006	SWH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPGPUB text search (see attached)	4/13/2006	SWH